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Responsible committee: PEL/42 Testing techniques for high voltages and currents

Interested committees:

Title: Draft BS EN 60060-3 Ed.2.0 BS EN IEC 60060-3 High-voltage test techniques. Part 3: Definitions and requirements for on-site testing.

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- i) has any issues related to 3rd party IPR, patent or copyright
- ii) affects other national standard(s)
- iii) requires additional national guidance or information

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Introduction

This draft standard is based on national and international discussions. Your comments on this draft are invited and will assist in the preparation of the consequent standard.

For international standards, comments will be reviewed by the relevant UK national committee before sending the consensus UK vote and comments to the international committee, which will then decide appropriate action. If the international standard is approved, it is usual for the text to be published as a British Standard.

For national standards, comments will be reviewed by the relevant UK national committee and the resulting standards published as a British Standard.

UK Vote

Please indicate whether you consider the UK should submit a negative (with supporting technical reasons) or positive vote on this draft. Please indicate if you are aware of any reason why this draft standard should not be published as a British Standard.

Submission of Comments

- **Annotated drafts are not acceptable and will be rejected.**
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Template for comments and secretariat observations

Date: xx/xx/20xx	Document: ISO/DIS xxxx
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1	2	(3)	4	5	(6)	7
MB	Clause No./ Subclause No./Annex (e.g. 3.1)	Paragraph/ Figure/Table/Note	Type of comment	Comment (justification for change) by the MB	Proposed change by the MB	Secretariat observations on each comment submitted
	3.1	Definition 1	ed	Definition is ambiguous and needs clarifying.	Amend to read '...so that the mains connector to which no connection...'	
	6.4	Paragraph 2	te	The use of the UV photometer as an alternative cannot be supported as serious problems have been encountered in its use in the UK.	Delete reference to UV photometer.	



42/465/CD

COMMITTEE DRAFT (CD)

PROJECT NUMBER: IEC 60060-3 ED2	
DATE OF CIRCULATION: 2025-09-05	CLOSING DATE FOR COMMENTS: 2025-10-31
SUPERSEDES DOCUMENTS:	

IEC TC 42 : HIGH-VOLTAGE AND HIGH-CURRENT TEST TECHNIQUES	
SECRETARIAT: Canada	SECRETARY: Mr Howard G. Sedding
OF INTEREST TO THE FOLLOWING COMMITTEES: TC 14,TC 17,SC 17A,SC 17C,SC 18A,TC 23,TC 32,TC 36,TC 37,TC 38,TC 122	HORIZONTAL FUNCTION(S):
ASPECTS CONCERNED:	

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Recipients of this document are invited to submit, with their comments, notification of any relevant patent rights of which they are aware and to provide supporting documentation.

Recipients of this document are invited to submit, with their comments, notification of any local regulations or technical reasons that may exist and should be considered should this proposal proceed, recognizing that failure to address such requirements could result in the need for new or existing "In Some Countries" clauses. (SEE [AC/22/2007](#) OR [NEW GUIDANCE DOC](#)).

TITLE:

High-voltage test techniques - Part 3: Definitions and requirements for on-site testing

NOTE FROM TC/SC OFFICERS:

At the MT 13 meeting in Wuhan last year, it was determined that a large component of IEC 60060-3 was a duplicate of information contained in IEC 60060-1. Consequently, it was decided to amend/revise 60060-1 to incorporate those elements of 60-3 that specifically concern on-site testing into 60-1 and, ultimately, withdraw 60-3. This CD is the result of these considerations in MT 4 and MT 13. Although IEC 60060-1 is affected by this project, only 60-3 is in a maintenance cycle hence the upload of the document as a CD under 60-3 maintenance.

The path forward for both IEC 60060-1 and 60060-3 will be discussed at the next TC 42 plenary.

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INTERNATIONAL ELECTROECHNICAL COMMISSION

HIGH-VOLTAGE TEST TECHNIQUES –

Part 3: Definitions and requirements for on-site testing

FOREWORD

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International Standard IEC 60060-3 has been prepared by IEC technical committee 42: High-voltage testing techniques.

The text of this standard is based on the following documents:

FDIS	Report on voting
42/203/FDIS	42/204/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

Terms used throughout this standard which have been defined in Clause 3 are written in **bold type**.